

Class II Permissive Change TEST REPORT

1. Applicant

Name : SAMSUNG ELECTRONICS CO., LTD.
Address : 416 Maetan3-Dong Yeongtong-gu, Suwon city,
Gyeonggi-Do, Korea 443-742

2. Products

Name : AT&T HomeManager
Model/Type : SMT-i8120
Manufacturer : SAMSUNG ELECTRONICS CO., LTD.

3. Test Standard : FCC CFR 47 Part 15, Subpart C & D

4. Test Method : ANSI C63.17-2006 / ANSI C63.4-2003

5. Test Result : Positive

6. Date of Application : May 26, 2008

7. Date of Issue : June 19, 2008

Tested by



Sung-Kyu Cho

Telecommunication Team
Engineer

Approved by



Seok-Jin Kim

Telecommunication Team
Manager

The test results contained apply only to the test sample(s) supplied by the applicant, and this test report shall not be reproduced in full or in part without approval of the KTL in advance.

Korea Testing Laboratory

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I . GENERAL INFORMATION

1.1 Applicant (Client)

Name	SAMSUNG ELECTRONICS CO., LTD.
Address	416 Maetan3-Dong Yeongtong-gu, Suwon city, Gyeonggi-Do, Korea 443-742
Contact Person	Bae, HagYoun
Telephone No.	+82-31-279-4387
Facsimile No.	+82-31-279-0389
E-mail address	Hagyoun.bae@samsung.com

1.2 Equipment (EUT)

Type of equipment	UPCS Handset
Model Name	SMT-i8120
FCC ID	A3LSMT-I8120
Operating Standard	DECT
Operating Frequency	1921.536 ~ 1928.448 MHz
Type of Modulation	TDMA
Number of channels	5 RF Channels, 5x12=60 TDMA duplex Channels
Type of Modulation	GFSK
Antenna	2 build-in antennas which support Antenna Diversity
Temperature Range	-20 ~ +50 ℃
Manufacturer Name	SAMSUNG ELECTRONICS CO., LTD.
Manufacturer Address	259, Gongdan-Dong, Gumi-City, Gyeongsangbuk-Do, 730-030, Korea

1.3 Testing Laboratory

Testing Place	Korea Testing Labortory (KTL) 516 Hae-an-ro, Sa-dong, Sangnok-gu, Ansan-si, Gyeonggi-do, 426-901, KOREA
Test Engineer	Sungkyu Cho
Telephone number	+82 31 500 0312
Facsimile number	+82 31 500 0159
E-mail address	skcho@ktl.re.kr
Other Comments	

1.4 Technical specifications

Frequency Band	1920 ~ 1930 MHz
Frame Period	10 ms
Time Slot Length	416.67 us
Slots	12 RX, 12 TX slots
Slot Structure	6 active duplex pairs per frame
Bit Rate	1.152 Mbit
Number of channels	5 RF Channels, 5x12=60 TDMA duplex Channels

Frequency Channel	Frequency
Channel 1	1921.536 MHz
Channel 2	1923.264 MHz
Channel 3	1924.992 MHz
Channel 4	1926.720 MHz
Channel 5	1928.448 MHz

II. SUMMARY OF TEST RESULTS

Testing performed for : SAMSUNG ELECTRONICS CO., LTD.

Equipment Under Test : SMT-i8120

Receipt of Test Sample : May 26, 2008

Test Start Date : June 10, 2008

Test End Date : June 19, 2008

The following table represents the list of measurements required under the FCC CFR47 Part 15 Subpart D.

Name of Test	FCC Part	Test Procedure	Verdict
Radiated Out of Band Emission	15.209(a)	ANSI C63.4	Pass

Note 1 : This report is for a Class II Permissive change. The device uses the same RF module as the originally approved device. The differences are as follows:

- 1) Modifying the DECT antennas with higher gain in 1.92GHz ~1.93GHz.
- 2) Changing some components Handset for TIA standard
- 3) Modified PCB layout to accommodate the changing components.
- 4) Minor EMI changes.

Note 2 : Test results reported in this document relate only to the items tested

Note 3 : The required tests demonstrated compliance as per client declaration of test configuration, monitoring methodology and associated pass/fail criteria

Note 4 : Test results apply only to the item(s) tested

*** Modifications required for compliance**

No modifications were implemented by KTL.

All results in this report pertain to the un-modified sample provided to KTL.

III. TEST FACILITY

3.1 Korea Testing Laboratory test location

All tests were conducted at Korea Testing Laboratory. The site address is 516 Hae-an-ro, Sa-dong, Sangnok-gu, Ansan-si, Gyeonggi-do, 426-901, KOREA. The radiated emission test site is a 10-meter semi-anechoic chamber. The chamber meets the characteristics of CISPR 16-1:1993 and ANSI C63.4: 1992. For measurements, a remotely controlled flush-mount metal-top turntable is used to rotate the EUT a full 360 degrees. A remote controlled non-conductive antenna mast is used to scan the antenna height from one to four meters.



The FCC registration number is 408324. The Industry Canada filing number for this site is 6298.

IV. TEST RESULTS

4.1 Radiated Out of Band Emission

4.1.1. Test procedure – FCC Part 15.209

4.1.1.1 Preliminary Testing for Reference

Preliminary testing was performed in a KTL absorber-lined room to determine the emission characteristics of the EUT. The EUT was placed on the wooden table which has dimensions of 0.8 meters in height, 1 meter in length and 1.5 meters in width. Receiving antenna (Biconi-Log antenna : 30 to 1000 MHz or Horn Antenna : 1 to 40 GHz) was placed at the distance of 3 meter from the EUT.

An attempt was made to maximize the emission level with the various configurations of the EUT. Emission levels from the EUT with various configurations were examined on a spectrum analyzer connected with a RF amplifier and graphed.

The emission was within the illumination area of the 3 dB beam width of the antenna so that the maximum emission from the EUT is measured.

4.1.1.2 Final Radiated Emission Test at an Absorber-Lined Room

The final measurement of radiated field strength was carried out in a KTL Absorber-Lined Room that was listed up at FCC according to the "Radiated Emissions Testing" procedure specified by ANSI C63.4.

Based on the test results in preliminary test, measurement was made in same test set up and configuration which produced maximum emission level. Receiving antenna was installed at 3-meter distance from the EUT, and was connected to an EMI receiver.

Turntable was rotated through 360 degrees and receiving antenna height was varied from 1 to 4 meters above the ground plane to read maximum emission level. Receiving antenna polarization was changed vertical and horizontal. The worst value was recorded.

If necessary, the radiated emission measurements could be performed at a closer distance than specified distance to ensure higher accuracy and their results were extrapolated to the specified distance using an inverse linear distance extrapolation factor (20 dB/decade) as per Section 15.31(f).

The maximum emission level from the EUT occurred in such configuration as shown in the following photograph.

Tested in x, y, z axis and worst case results are reported

The maximum frequency range measuring with the spectrum from 30 MHz to 10 th Harmonic is investigated with the transmitter

4.1.2. Limits

(a) Except for Class A digital devices, the field strength of radiated emissions from unintentional radiators at a distance of 3 meters shall not exceed the following values:

Frequency of Emission (MHz)	Field strength (Microvolts/meters)
30 – 88	100
88 – 216	150
216 – 960	200
Above 960	500

(b) The field strength of radiated emissions from a Class A digital device, as determined at a distance of 10 meters, shall not exceed the following :

Frequency of Emission (MHz)	Field strength (Microvolts/meters)
30 – 88	90
88 – 216	150
216 – 960	210
Above 960	300

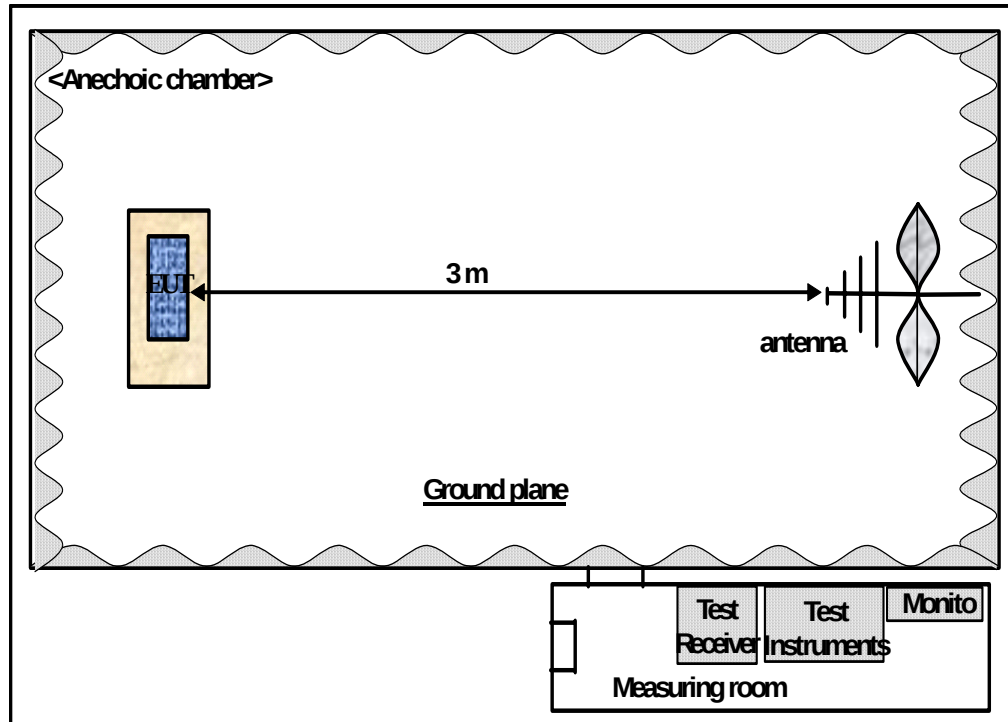
4.1.3. Sample calculation

The emission level measured in decibels above one microvolt (dB μV) was following sample calculation.

For example :

Measured Value at <u>48.2</u> MHz	17.6 dB μV
Antenna Factor & Cable loss	14.3 dB
- Preamplifier	0.0 dB
= Radiated Emission	31.9 dB $\mu V/m$

4.1.4. Test configuration



4.1.5 Test result (Lowest channel)

Measurement mode	Lowest Channel Transmit mode								
Resolution Bandwidth	■ Peak & Average (3dB Bandwidth : 1MHz for above 1GHz) ■ Quasi-Peak (6dB Bandwidth : 120kHz for below 1GHz)								
Frequency (MHz)	D.M.	A.P.	Measured Value (dB μ V)	A.F.+ C.L. (dB)	A.G. (dB)	D.C.F. (dB)	Emission Level (dB μ V/m)	Limit (dB μ V/m)	** Margin (dB)
353.12	Q	H	41.7	16.7	-32.8	0	25.6	46.0	-20.4
518.40	Q	V	19.0	20.6	-32.7	0	6.9	46.0	-39.1
539.12	Q	V	37.2	21.1	-32.7	0	25.6	46.0	-20.4
642.80	Q	H	22.6	23.3	-32.7	0	13.2	46.0	-32.8
3843.08	A	H/V	--	--	--	--	--	54.0	--
5764.62	A	H/V	--	--	--	--	--	54.0	--

Note

The observed EMI receiver (ESIB) & Spectrum Analyer(E4448A) noise floor level was 2.0 dB μ V. And all other emissions not reported on data were more than 25 dB below the permitted level.

* D.M. : Detect Mode (P : Peak, Q : Quasi-Peak, A : Average)
 A.P. : Antenna Polarization (H : Horizontal, V : Vertical)
 A.F. : Antenna Factor
 C.L. : Cable Loss
 A.G. : Amplifier Gain
 D.C.F. : Distance Correction Factor
 < : Less than

"--" indicates the spurious emission could not be detected due to noise limitations or ambients.

** Margin (dB) = Emission Level (dB) - Limit (dB)

4.1.5 Test result (Highest channel)

Measurement mode		Highest Channel Transmit mode							
Resolution Bandwidth		Peak & Average (3dB Bandwidth : 1MHz for above 1GHz) Quasi-Peak (6dB Bandwidth : 120kHz for below 1GHz)							
Frequency (MHz)	D.M.	A.P.	Measured Value (dB μ V)	A.F.+ C.L. (dB)	A.G. (dB)	D.C.F. (dB)	Emission Level (dB μ V/m)	Limit (dB μ V/m)	** Margin (dB)
353.22	Q	H	40.8	16.7	-32.8	0	24.7	46.0	-21.3
518.35	Q	V	21.2	20.6	-32.7	0	9.1	46.0	-36.9
539.30	Q	V	39.5	21.1	-32.7	0	27.9	46.0	-18.1
640.04	Q	H	22.9	23.3	-32.7	0	13.5	46.0	-32.5
3856.90	A	H/V	--	--	--	--	--	54.0	--
5785.35	A	H/V	--	--	--	--	--	54.0	--

Note

The observed EMI receiver (ESIB) & Spectrum Analyser(E4448A) noise floor level was 2.0 dB μ V. And all other emissions not reported on data were more than 25 dB below the permitted level.

* D.M. : Detect Mode (P : Peak, Q : Quasi-Peak, A : Average)
A.P. : Antenna Polarization (H : Horizontal, V : Vertical)
A.F. : Antenna Factor
C.L. : Cable Loss
A.G. : Amplifier Gain
D.C.F. : Distance Correction Factor
< : Less than

"--" indicates the spurious emission could not be detected due to noise limitations or ambients.

** Margin (dB) = Emission Level (dB) - Limit (dB)

V. TEST EQUIPMENT

No.	Equipment	Manufacturer	Model	S/N	Effective Cal.Duration
1	EMI Receiver (20 Hz ~ 26.5 GHz)	R&S	ESIB	100280	08/17/2007 ~ 08/17/2008
2	Spectrum Analyzer (100 Hz ~ 26.5 GHz)	Agilent	E4407B	US41443316	12/01/2007 ~ 12/01/2008
3	Spectrum Analyzer (3 Hz ~ 50 GHz)	Agilent	E4448A	MY43360322	08/30/2007 ~ 08/30/2008
4	Pre-Amplifier (100 kHz ~ 1 GHz)	SONOMA.	310N	186270	08/25/2007 ~ 08/25/2008
5	Pre-Amplifier (0.5 GHz ~ 26.5 GHz)	Agilent	83017A	MY39500982	04/02/2008 ~ 04/02/2009
6	LISN(50 Ω , 50 μ H) (10 kHz ~ 100 MHz)	R&S	ESH3-Z5	826789009	07/05/2007 ~ 07/05/2008
7	Biconi-Log Ant. (30 MHz ~ 1000 MHz)	Schwarzbeck	VULB9168	9168-180	08/24/2007 ~ 08/24/2008
8	Horn Ant. (1 GHz ~ 18 GHz)	EMCO	3115	9012-3595	03/26/2007 ~ 03/26/2009
9	Horn Ant. (18 GHz ~ 40 GHz)	EMCO	3116	2664	03/26/2007 ~ 03/26/2009
10	Active Loop Ant. (9 kHz ~ 30 MHz)	EMCO	6502	2532	06/08/2007 ~ 06/08/2008
11	DC Power Supply	Agilent	E4356A	MY41000296	10/01/2007 ~ 10/01/2008
12	Power Meter	Agilent	E4417A	GB4129075	09/17/2007 ~ 09/17/2008
13	Bluetooth tester	anrisu	MT8852B	6K00006994	03/03/2008 ~ 03/03/2009